

Chipsmall Limited consists of a professional team with an average of over 10 year of expertise in the distribution of electronic components. Based in Hongkong, we have already established firm and mutual-benefit business relationships with customers from, Europe, America and south Asia, supplying obsolete and hard-to-find components to meet their specific needs.

With the principle of "Quality Parts, Customers Priority, Honest Operation, and Considerate Service", our business mainly focus on the distribution of electronic components. Line cards we deal with include Microchip, ALPS, ROHM, Xilinx, Pulse, ON, Everlight and Freescale. Main products comprise IC, Modules, Potentiometer, IC Socket, Relay, Connector. Our parts cover such applications as commercial, industrial, and automotives areas.

We are looking forward to setting up business relationship with you and hope to provide you with the best service and solution. Let us make a better world for our industry!



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TECHNICAL DATA SHEET

6 Lake Street, Lawrence, MA 01841 1-800-446-1158 / (978) 620-2600 / Fax: (978) 689-0803

Website: http://www.microsemi.com

NPN POWER SILICON TRANSISTOR

Qualified per MIL-PRF-19500/534

DEVICES

2N5002 2N5004

JAN
JANTX
JANTXV
JANS

ABSOLUTE MAXIMUM RATINGS ($T_C = +25^{\circ}C$ unless otherwise noted)

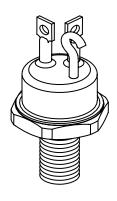
Parameters / Test Conditions	Symbol	Value	Unit
Collector-Emitter Voltage	V_{CEO}	80	V
Collector-Base Voltage	V_{CBO}	100	V
Emitter-Base Voltage	V_{EBO}	5.5	V
Collector Current	I_{C} $I_{C}^{(3)}$	5.0 10	A
Total Power Dissipation @ $T_A = +25^{\circ}C^{(1)}$ @ $T_C = +25^{\circ}C^{(2)}$	P _T	2.0 58	W
Operating & Storage Junction Temperature Range	T_J, T_{stg}	-65 to +200	°C
Thermal Resistance, Junction-to Case	$R_{ heta JC}$	3.0	°C/W
Thermal Resistance, Junction-to Ambient	$R_{\theta JA}$	88	°C/W

Note:

- 1) Derate linearly 11.4 mW/°C for $T_A > +25$ °C
- 2) Derate linearly 331 mW/°C for $T_C > +25$ °C
- 3) This value applies for $P_W \le 8.3$ ms, duty cycle $\le 1\%$

ELECTRICAL CHARACTERISTICS ($T_A = +25^{\circ}C$, unless otherwise noted)

Parameters / Test Conditions	Symbol	Min.	Max.	Unit	
OFF CHARACTERISTICS					
Collector-Emitter Breakdown Voltage I _C = 100mAdc	V _{(BR)CEO}	80		Vdc	
Collector-Emitter Cutoff Current $V_{CE} = 40Vdc$, $I_B = 0$	I_{CEO}		50	μAdc	
$\begin{aligned} & \text{Collector-Emitter Cutoff Current} \\ & V_{\text{CE}} = 60 \text{Vdc}, V_{\text{BE}} = 0 \text{Vdc} \\ & V_{\text{CE}} = 100 \text{Vdc}, V_{\text{BE}} = 0 \text{Vdc} \end{aligned}$	I_{CES}		1.0 1.0	μAdc mAdc	
Emitter-Base Cutoff Current $V_{BE} = 4.0 V dc, I_C = 0$ $V_{BE} = 5.5 V dc, I_C = 0$	I_{EBO}		1.0 1.0	mAdc	



TO-59



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DYNAMIC CHARACTERISTICS

Parameters / Test Conditions		Symbol	Min.	Max.	Unit
Forward-Current Transfer Ratio					
$\begin{split} I_{C} &= 50 \text{mAdc}, V_{CE} = 5.0 \text{Vdc} \\ I_{C} &= 2.5 \text{Adc}, V_{CE} = 5.0 \text{Vdc} \\ I_{C} &= 5.0 \text{Adc}, V_{CE} = 5.0 \text{Vdc} \end{split}$	2N5002	$ m h_{FE}$	20 30 20	90 	
$\begin{split} I_{C} &= 50 \text{mAdc}, V_{CE} = 5.0 \text{Vdc} \\ I_{C} &= 2.5 \text{Adc}, V_{CE} = 5.0 \text{Vdc} \\ I_{C} &= 5.0 \text{Adc}, V_{CE} = 5.0 \text{Vdc} \end{split}$	2N5004		50 70 40	200 	
Base-Emitter Voltage Non-Saturated $V_{CE} = 5.0 Vdc$, $I_C = 2.5 Adc$		$ m V_{BE}$		1.45	Vdc
$\begin{aligned} & \text{Collector-Emitter Saturation Voltage} \\ & \text{I}_{\text{C}} = 2.5 \text{Adc}, \text{I}_{\text{B}} = 250 \text{mAdc} \\ & \text{I}_{\text{C}} = 5.0 \text{Adc}, \text{I}_{\text{B}} = 500 \text{mAdc} \end{aligned}$		V _{CE(sat)}		0.75 1.5	Vdc
$\begin{aligned} &\text{Base-Emitter Saturation Voltage} \\ &\text{I}_{\text{C}} = 2.5 \text{Adc, I}_{\text{B}} = 250 \text{mAdc} \\ &\text{I}_{\text{C}} = 5.0 \text{Adc, I}_{\text{B}} = 500 \text{mAdc} \end{aligned}$		V _{BE(sat)}		1.45 2.2	Vdc

DYNAMIC CHARACTERISTICS

Parameters / Test Conditions		Symbol	Min.	Max.	Unit
Magnitude of Common Emitter Small-Signal Sho Transfer Ratio $I_{C}=500 mA, V_{CE}=5.0 Vdc, f=10 MHz$	ort-Circuit. Forward Current 2N5002 2N5004	h _{fe}	6.0 7.0		
Output Capacitance $V_{CB} = 10 \text{Vdc}$		C_{obo}		250	pF

SWITCHING CHARACTERISTICS

Parameters / Tes	Conditions	Symbol	Min.	Max.	Unit
Turn-On Time	$I_C = 5Adc; I_{B1} = 500mAdc$	t _{on}		0.5	μs
Storage Time	$I_{B2} = -500 \text{mAdc}$	$t_{\rm s}$		1.4	μs
Fall Time	$V_{BE(OFF)} = 3.7 \text{Vdc}$	t_{f}		0.5	μs
Turn-Off Time	$R_L = 6\Omega$	$t_{ m off}$		1.5	μs

SAFE OPERATING AREA

DC Tests

 $T_C = +25^{\circ}C$, $V_{CE} = 0$, tp = 1s, 1 Cycle

Test 1

 $V_{CE} = 12Vdc$, $I_C = 5.0Adc$

Test 2

 $V_{CE} = 32Vdc$, $I_C = 1.7Adc$

Test 3

 $V_{CE} = 80 \text{Vdc}, I_C = 100 \text{mAdc}$